

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

WEEL, MARTIN

Examiner

OANH DUONG

Art Unit

2455

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2002/0168938	11-2002	Chang, Chin-Chi	455/41
*	B US-5,616,876	04-1997	Cluts, Jonathan C.	84/609
*	C US-2003/0204439 A1	10-2003	Cullen, Andrew A. III	705/11
*	D US-2003/0236843 A1	12-2003	Weber et al.	709/206
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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V	
W	
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